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| Search Notes  | Application/Control No. 10027302 | Applicant(s)/Patent Under Reexamination BOUET, STEPHANE |
| | Examiner Dalencourt, Yves | Art Unit 2157 |

| SEARCHED | | | |
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| Class | Subclass | Date | Examiner |
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| SEARCH NOTES | | |
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| Search Notes | Date | Examiner |
| WEST (updated text search) | 06/27/2007 | YD |
| WEST (updated text search) | 07/02/2007 | YD |
| STIC (EIC Search) | 06/28/2007 | YD |
| WEST (updated text search) | 12/23/2007 | YD |
| WEST (updated text search) | 06/22/2008 | YD |
| WEST (updated text search) | 08/15/2009 | YD |
| IEEE Xplore | 08/15/2009 | YD |

| INTERFERENCE SEARCH | | | |
|------------------------------------------|----------|------------|----------|
| Class | Subclass | Date | Examiner |
| WEST (updated text search 709/230) | | 08/15/2009 | YD |

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